

<b>Notice of References Cited</b>	Application/Control No. 10/658,177	Applicant(s)/Patent Under Reexamination SMITH, JOHN W.	
	Examiner M. Wilczewski	Art Unit 2822	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,707,149	03-2004	Smith, John W.	257/723
	B	US-6,429,112	08-2002	Smith et al.	438/611
	C	US-6,169,328	01-2001	Mitchell et al.	257/778
	D	US-2002/0148639	10-2002	Smith et al.	174/255
	E	US-2003/0168725	09-2003	Warner et al.	257/686
	F	US-6,602,740	08-2003	Mitchell, Craig S.	438/127
*	G	US-6,590,287	07-2003	Ohuchi, Akira	257/738
*	H	US-6,528,343	03-2003	Kikuchi et al.	438/106
*	I	US-6,525,429	02-2003	Kovac et al.	257/778
*	J	US-6,338,492	01-2002	Schilling et al.	277/630
	K	US-6,472,762	10-2002	Kutlu, Zafer S.	257/778
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.